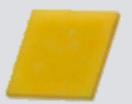
Middle Power LED Series Flip Chip Package

LM101A





LM101A opens up a new world of lighting design with its high output and small form factors





Features & Benefits

- Greater freedom of design with compact package size
- High degree of reliability with plastic-free structure
- Low thermal resistance
- High efficiency providing optimized solution
- Compact footprint (1.15 x 1.15 mm)

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1. Characteristics

a) Absolute Maximum Rating

ltem	Symbol	Rating	Unit	Condition
Operating Temperature	Ta	-40 ~ +85	°C	-
Storage Temperature	T_{stg}	-40 ~ +120	°C	-
LED Junction Temperature	T _j	125	°C	-
Forward Current	l _F	450	mA	-
Assembly Process Temperature	-	260 <10	°C s	-
ESD (HBM)	-	±2	kV	-

Note: It is recommended minimum current 10mA in order to avoid un-even brightness, and may vary depending on circuit configuration.

b) Electro-optical Characteristics (I_F = 150 mA, T_s = 85 °C)

ltem	Unit	Rank	Bin	Min.	Тур.	Max.
Forward Voltage (V _F)	V	6E	6A	2.7	-	2.9
Forward voltage (vF)	V	0E	AE	2.9	-	3.1
Reverse Voltage (@ -10 μA)	V			-10.0	-	-
Color Rendering Index (Ra)	-	8		80	-	-
Special CRI (R9)	-			0	-	-
Thermal Resistance (junction to chip point)	K/W			-	2	-
Beam Angle	0			-	150	-

Note: Samsung maintains measurement tolerance of : Forward voltage = ± 0.1 V, Luminous flux = ± 5 %, CRI = ± 3 , R9 = ± 6.5

c) Luminous Flux Characteristics (I_F = 150 mA, T_s = 85 °C)

		Nominal	S	SY	S	Z	S	A	S	В	S	C	S	D	S	E	S	F	S	G
Item	CRI	CCT (K)	Min.	Max.																
			35	39	39	43	43	47	47	51	51	55	55	59	59	63	63	67	67	71
		3000																		
		3500																		
	70	4000																		
	70	5000																		
		5700																		
		6500																		
		2700																		
Luminous		3000																		
Flux (Φv)		3500																		
	80	4000																		
		5000																		
		5700																		
		6500																		
		2700																		
	90	3000																		
		3500																		

Note:

- 1) The LM101A is tested in pulsed condition at rated test current (10 ms pulse width)
- 2) Calculated flux values are for reference only
- 3) Samsung maintains measurement tolerance of: luminous flux = ± 5 %

2. Product Code Information (IF = 150 mA, T_s = 85 °C)

1	2	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18
S	С	Р	8	W	т	7	8	н	Р	L	1	W	L	S	0	6	Е

Digit	PKG Information	Code	Specification
1 2 3	Samsung Chip	SCP	
		7	Min. 70
4	CRI	8	Min. 80
		9	Min. 90
		w	2700
		V	3000
		U	3500
5	CCT (K)	Т	4000
		R	5000
		Q	5700
		Р	6500
6	Chip Shape	Т	Square
7 8 9	Chip Size (µm)	78H	780x780x170μm
10 11 12	Product Purpose	PL1	PoC for Lighting
		w	2700K
		V	3000K
		U	3500K
13	CCT (K)	Т	4000K
		R	5000K
		Q	5700K
		Р	6500K
14	MacAdam Step	L 	Single Bin for MacAdam 5-step L(MacAdam 5-step Bin) Single Bin for MacAdam 3-step U(MacAdam 3-step Bin)
15 16	Luminous Flux (lm)	U S0	Bin ov c7 c4 op co op c5 c5
13 10	Luminous Flux (IIII)	30	Code: SY, SZ, SA, SB, SU, SD, SE, SF, SG 6A 2.7-2.9
17 18	Forward Voltage (V)	6E	2.7~3.1 Bin Code: AE 2.9~3.1

a) Luminous Flux Bins (I_F = 150 mA, T_s = 85 °C)

CRI (R₃) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _ν , lm)
			SD	55 ~ 59
	3000	SCP7VT78HPL1V☆S06E	SE	59 ~ 63
			SF	63 ~ 67
			SD	55 ~ 59
	3500	SCP7UT78HPL1U☆S06E	SE	59 ~ 63
			SF	63 ~ 67
			SE	59 ~ 63
	4000	SCP7TT78HPL1T☆S06E	SF	63 ~ 67
70			SG	67 ~ 71
70			SE	59 ~ 63
	5000	SCP7RT78HPL1R☆S06E	SF	63 ~ 67
			SG	67 ~ 71
			SE	59 ~ 63
	5700	SCP7QT78HPL1Q☆S06E	SF	63 ~ 67
			SG	67 ~ 71
			SE	59 ~ 63
	6500	SCP7PT78HPL1P☆S06E	SF	63 ~ 67
			SG	67 ~ 71

Note: "☆" can be "L" (Single bin for MacAdam 5-step), "U" (Single bin for MacAdam 3-step)

a) Luminous Flux Bins ($I_F = 150 \text{ mA}, T_s = 85 \text{ }^{\circ}\text{C}$)

CRI (R₃) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _v , lm)
			SB	47 ~ 51
	2700	SCP8WT78HPL1W☆S06E	SC	51 ~ 55
			SD	55 ~ 59
			SC	51 ~ 55
	3000	SCP8VT78HPL1V☆S06E	SD	55 ~ 59
			SE	59 ~ 63
			SC	51 ~ 55
	3500	SCP8UT78HPL1U☆S06E	SD	55 ~ 59
			SE	59 ~ 63
			SD	55 ~ 59
80	4000	SCP8TT78HPL1T☆S06E	SE	59 ~ 63
			SF	63 ~ 67
			SD	55 ~ 59
	5000	SCP8RT78HPL1R☆S06E	SE	59 ~ 63
			SF	63 ~ 67
			SC	51 ~ 55
	5700	SCP8QT78HPL1Q::\square\	SD	55 ~ 59
			SE	59 ~ 63
			SC	51 ~ 55
	6500	SCP8PT78HPL1P☆S06E	SD	55 ~ 59
			SE	59 ~ 63

Note: "\$%"\$ can be "L" (Single bin for MacAdam 5-step) "U" (Single bin for MacAdam 3-step)

a) Luminous Flux Bins (I_F = 150 mA, T_s = 85 °C)

CRI (R _a) Min.	Nominal CCT (K)	Product Code	Flux Bin	Flux Range (Φ _v , lm)
			SY	35 ~ 39
	2700	SCP9WT78HPL1W☆S06E	SZ	39 ~ 43
			SA	43 ~ 47
			SY	35 ~ 39
90	3000	SCP9VT78HPL1V☆S06E	SZ	39 ~ 43
			SA	43 ~ 47
			SZ	39 ~ 43
	3500	SCP9UT78HPL1U☆S06E	SA	43 ~ 47
			SB	47 ~ 51

Note: "☆" can be "L" (Single bin for MacAdam 5-step), "U" (Single bin for MacAdam 3-step)

b) Color Bins ($I_F = 150$ mA, $T_s = 85$ °C)

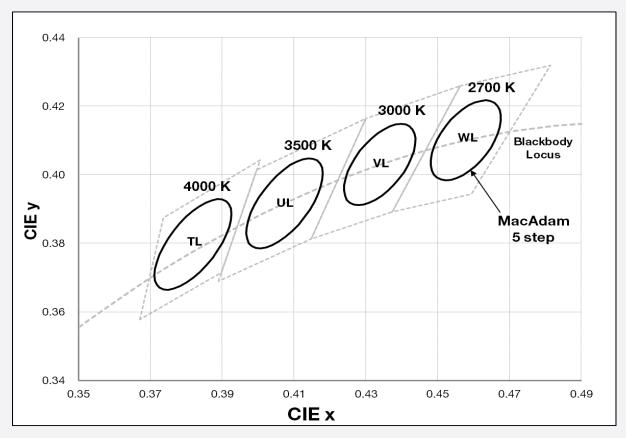
CRI Min.	Nominal CCT (K)	Product Code	Color Rank	Chromaticity Bins
	3000	CCD7\/T70 IDL 4\/ \ COCF	VL	VL
	3000	SCP7VT78HPL1V☆S06E	VU	VU
****	3500	SCP7UT78HPL1U☆S06E	UL	UL
	3300	SCF/UT/ONFLIU X SUGE	UU	UU
	4000	SCP7TT78HPL1T☆S06E	TL	TL
70	4000	SOF/II/OFFLIT % SUGE	TU	TU
70	5000	SCP7RT78HPL1R☆ S06E	RL	RL
	3000	SOF / KITOIIF LIK & SOOL	RU	RU
	5700	SCP7QT78HPL1Q☆ S06E	QL	QL
	3700	SCF/QT/OHFLIQ# 300L	QU	QU
	6500	SCP7PT78HPL1P☆S06E	PL	PL
	0300	SCF/FI/ONFLIFX SUCE	PU	PU
	2700	SCP8WT78HPL1W☆S06E	WL	WL
	2700	30F0W170HFL1W # 300L	WU	WU
	3000	SCP8VT78HPL1V☆ S06E	VL	VL
		30F0V170FFL1V × 300E	VU	VU
	3500	CCD011770UD1411A-C06E	UL	UL
		SCP8UT78HPL1U☆ S06E	UU	UU
80		SCP8TT78HPL1T☆ S06E	TL	TL
80	4000	30P81178FPL11 # 300E	TU	TU
****	5000	SCP8RT78HPL1R☆ S06E	RL	RL
	5000	SCPORT/OFFLIRE SUGE	RU	RU
	F700	00000770110140 4 0005	QL	QL
	5700	SCP8QT78HPL1Q☆ S06E	QU	QU
	CEOO	CODODT TO UDI 4D A COOF	PL	PL
	6500	SCP8PT78HPL1P☆S06E	PU	PU
	2700	CCDOWT70LIDLAW A COOF	WL	WL
	2700	SCP9WT78HPL1W ☆ S06E	WU	WU
00	0000	0000/17/01/01/1/ 0005	VL	VL
90	3000	SCP9VT78HPL1V☆S06E	VU	VU
	2500	CCD0117701D14114 COCT	UL	UL
	3500	SCP9UT78HPL1U☆ S06E	UU	UU

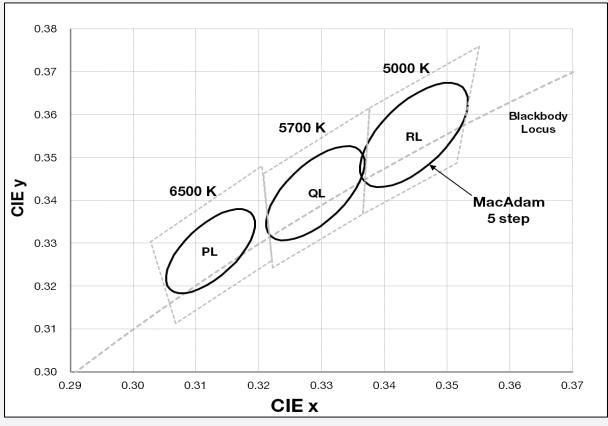
Note: "☆" can be "L" (Single bin for MacAdam 5-step), "U" (Single bin for MacAdam 3-step)

c) Voltage Bins (I_F = 150 mA, T_s = 85 °C)

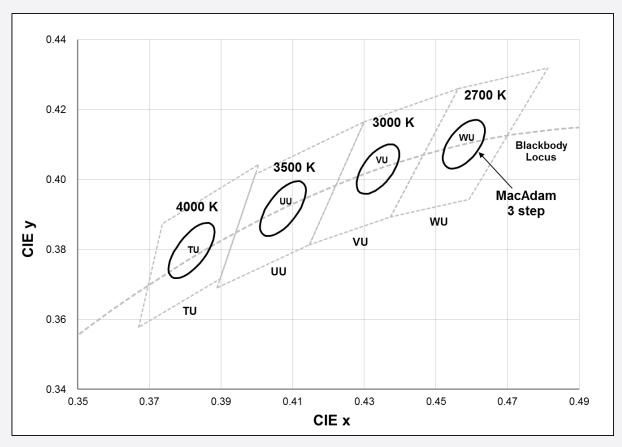
Nominal CCT (K)	CRI Min.	Product Code	Voltage Rank	Voltage Bin	Voltage Range (V)
			6E	6A	2.7 ~ 2.9
			OE	AE	2.9 ~ 3.1

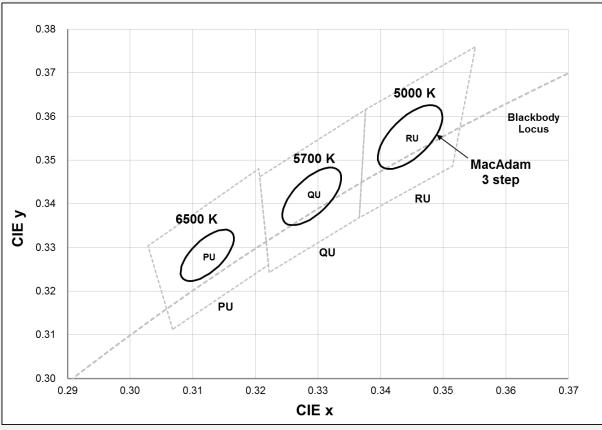
d) Chromaticity Region & Coordinates (IF = 150 mA, T_s = 85 $^{\circ}$ C) : "L" (Single bin for MacAdam 5-step)



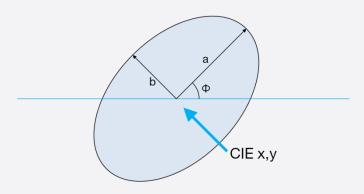


d) Chromaticity Region & Coordinates (I_F = 150 mA, T_s = 85 °C) : "U" (Single bin for MacAdam 3-step)





d) Chromaticity Region & Coordinates (I_F = 150 mA, T_s = 85 $^{\circ}$ C)



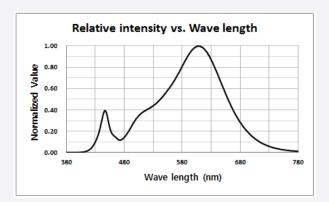
ССТ		Cen	ter point	Major-axis	Minor-axis	Rotation
	(K)	CIE x	CIE y	a	b	Ф
	2700	0.4578	0.4101	0.0081	0.0042	53.70
	3000	0.4338	0.4030	0.0083	0.0041	53.22
	3500	0.4073	0.3917	0.0093	0.0041	54.00
3 step (U code)	4000	0.3818	0.3797	0.0094	0.0040	53.72
	5000	0.3447	0.3553	0.0082	0.0035	59.62
	5700	0.3287	0.3417	0.0075	0.0032	59.10
	6500	0.3123	0.3282	0.0067	0.0029	58.57
	2700	0.4578	0.4101	0.0135	0.0070	53.70
	3000	0.4338	0.4030	0.0138	0.0068	53.22
	3500	0.4073	0.3917	0.0155	0.0068	54.00
5 step (L code)	4000	0.3818	0.3797	0.0157	0.0067	53.72
	5000	0.3447	0.3553	0.0137	0.0058	59.62
	5700	0.3287	0.3417	0.0125	0.0053	59.10
	6500	0.3123	0.3282	0.0112	0.0048	58.57

Note: Samsung maintains measurement tolerance of: Cx, $Cy = \pm 0.005$

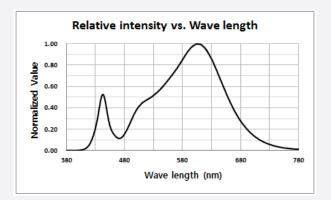
3. Typical Characteristics Graphs

a) Spectrum Distribution ($I_F = 150 \text{ mA}, T_s = 25 \text{ }^{\circ}\text{C}$)

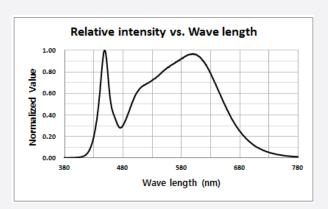
CCT: 2700 K



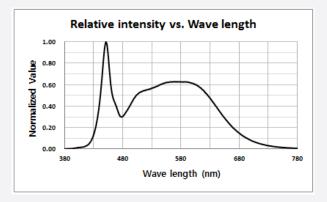
CCT: 3000 K



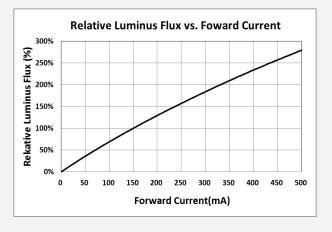
CCT: 4000 K

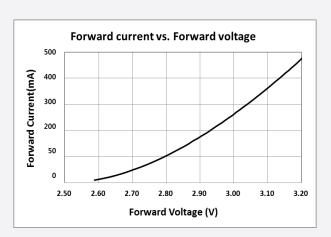


CCT: 5000 K

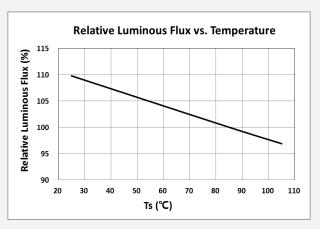


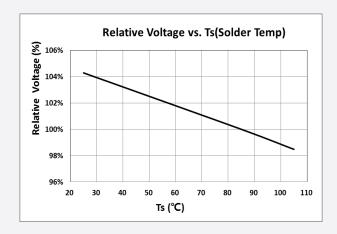
b) Forward Current Characteristics (T_s = 25 °C)



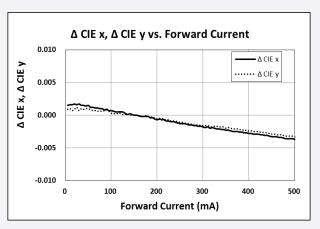


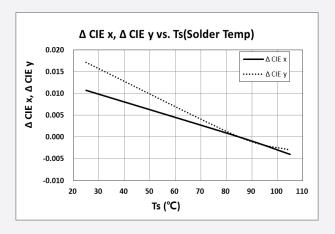
c) Temperature Characteristics (I_F = 150 mA)



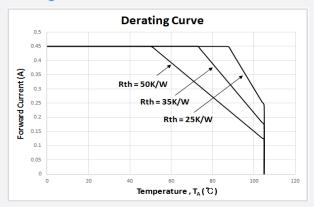


d) Color Shift Characteristics ($T_s = 25$ °C, $I_F = 150$ mA)



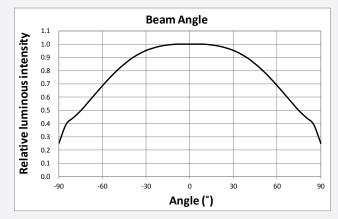


e) Derating Curve



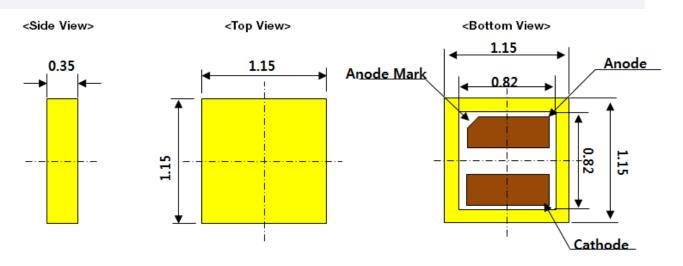
 R_{th} is measured after soldering of LED chip on the metal based substrate. *metal: aluminum (refer to page 17)

f) Beam Angle Characteristics (I_F = 150 mA)

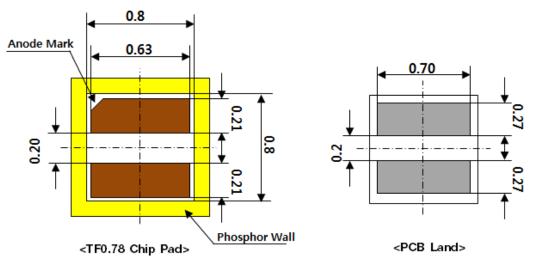


4. Outline Drawing & Dimension

- 1. Tolerance is ±0.10 mm
- 2. Do not place LEDs with pressure



<Recommended Land Pattern>

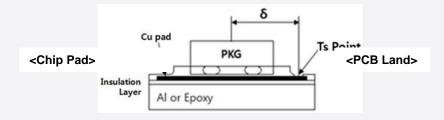


Ts Point & Measurement Method:

Measure nearest point from the center of LED chip (δ) as shown below.

Distance between chip center and T_s point (δ) = 3.5 mm

 $T_j = T_s + Power x Thermal resistance at <math>T_s (R_{j-s})$



Precautions:

- 1) This LED chip PKG does not contain built-in ESD protection device.
- 2) Pressure on the LEDs will influence to the reliability of the LEDs. Precautions should be taken to avoid strong pressure on the LEDs. Do not put stress on the LEDs during heating.
- 3) Re-soldering should not be done after the LEDs have been soldered. If re-soldering is unavoidable, LED's characteristics should be carefully checked before and after such repair.
- 4) Do not stack assembled PCBs together. Since materials of LEDs is soft, abrasion between two PCB assembled with LED might cause catastrophic failure of the LEDs.

5. Reliability Test Items & Conditions

a) Test Items

Test Item	Test Condition	Test Hour / Cycle	Sample Size
MSL Test	125 °C 24 h drying \rightarrow 60 °C, 60 % RH 120 h \rightarrow 260 °C 10 sec 3 cycles	1 cycle	11
Room Temperature Life Test	25 °C, Derated max current	1000 h	22
High Temperature Life Test	85 °C, Derated max current	1000 h	22
High Temperature Humidity Life Test	85 °C, 85 % RH, Derated max current	1000 h	22
Low Temperature Life Test	-40 °C, DC Derated max current	1000 h	22
Powered Temperature Cycle Test	-45 °C / 20 min \leftrightarrow 85 °C / 20 min, sweep 100 min cycle on/off: each 5 min, Derated max current	100 cycles	22
Thermal Shock	-45 °C / 15 min ↔ 125 °C / 15 min → Hot plate 180 °C	800 cycles	100
High Temperature Storage	120 °C	1000 h	11
Low Temperature Storage	-40 °C	1000 h	11
ESD (HBM)	R ₁ : 10 MΩ R ₂ : 1.5 kΩ C: 100 pF V: ±2 kV	5 times	5
Vibration Test	20~2000~20 Hz, 200 m/s², sweep 4 min X, Y, Z 3 direction, each 1 cycle	4 cycles	11
Mechanical Shock Test	1500 g, 0.5 ms	5 cycles	11

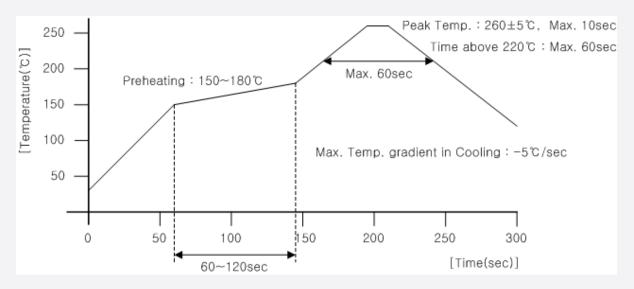
b) Criteria for Judging the Damage

ltem	Symbol	Test Condition $(T_s = 25 {}^{\circ}\text{C})$	Lir	Limit	
			Min	Max	
Forward Voltage	V_{F}	I _F = Derated max current	Init. Value * 0.9	Init. Value * 1.1	
Luminous Flux	Фv	I _F = Derated max current	Init. Value * 0.7	Init. Value * 1.1	

6. Soldering Conditions

a) Reflow Conditions (Pb free)

Reflow frequency: 2 times max.



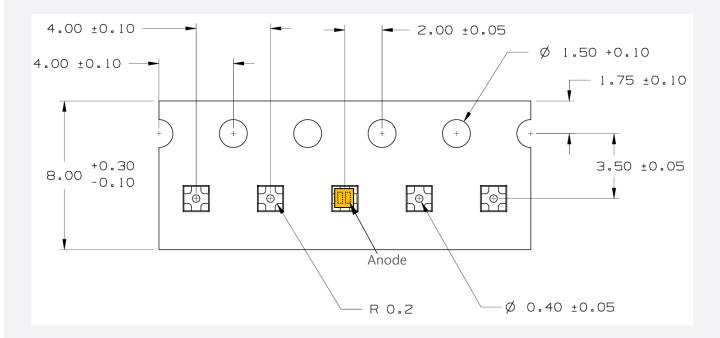
b) Manual Soldering Conditions

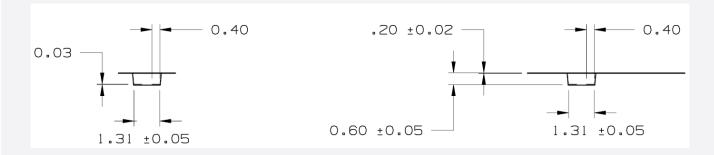
Not more than 5 seconds @ max. 300 °C, under soldering iron

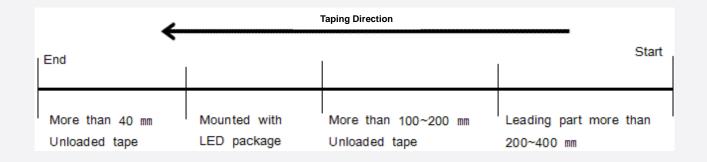
7. Tape & Reel

a) Taping Dimension

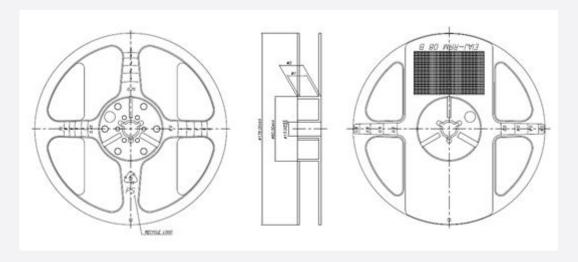
(unit: mm)







b) Reel Dimension



Width	W7	W2
8mm	9 ±0.3	11.9 ±1.0

Notes:

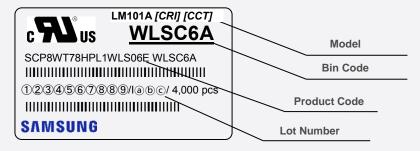
1) Quantity: The quantity/reel is 4,000 pcs

2) Cumulative Tolerance: Cumulative tolerance / 10 pitches is ± 0.2 mm

3) Packaging: P/N, Manufacturing data code no. and quantity are indicated on the aluminum packing bag

8. Label Structure

a) Label Structure



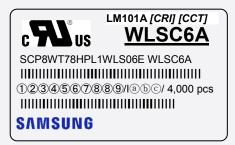
Note: Denoted product code and bin code above is only an example

Bin Code:

(a) (b): Chromaticity bin (refer to page 10-14)(c) (d): Luminous Flux bin (refer to page 7-9)(e) (f): Forward Voltage bin (refer to page 11)

b) Lot Number

The lot number is composed of the following characters:



123456789 / 180c / 4,000 pcs

(1)(2) : Production site (G3: Shenzhen China, G4: Guangzhou China, GB: Nanchang China)

③ : Product state (A: Normal, B: Bulk, C: First Production, R: Reproduction, S: Sample)

(4) : Year (Y: 2014, Z: 2015, A: 2016 ...)

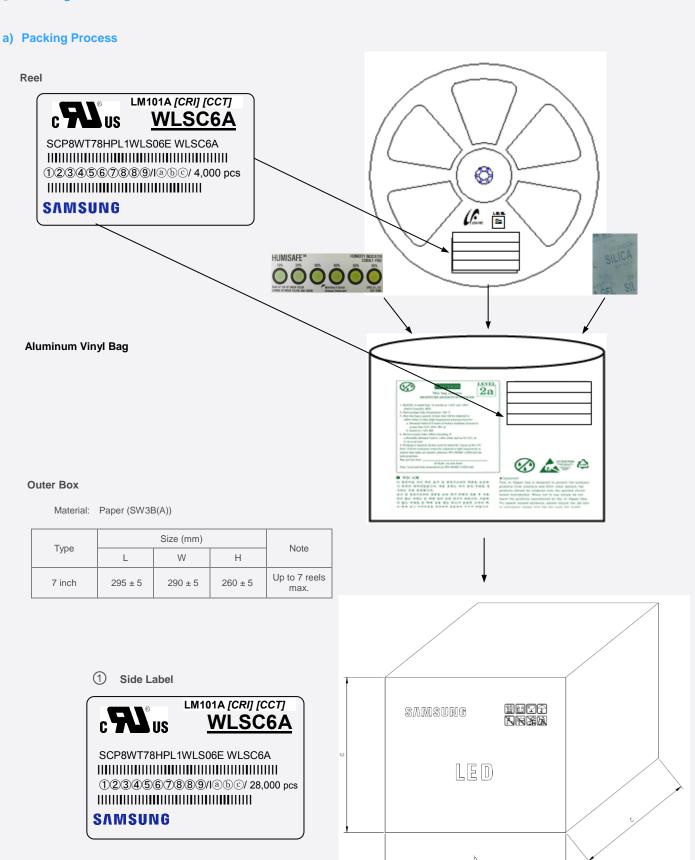
(5) : Month (1~9, A, B, C)

6 : Day (1~9, A, B~V)

(7)(8)(9): Product serial number $(001 \sim 999)$

(a)b)c : Reel number (001 ~ 999) or (AAA ~ ZZZ)

9. Packing Structure



b) Aluminum Vinyl Packing Bag



CAUTION

2a

This bag contains MOISTURE SENSITIVE DEVICES

- Shelf life in sealed bag: 12 months at <40°C and <90% relative humidity (RH)
- 2. Peak package body temperature: 240 °C
- After this bag is opened, devices that will be subjected to reflow solder or other high temperature processes must be:
 - a. Mounted within 672 hours at factory conditions of equal to or less than 30°C /60% RH, or
 - b. Stored at < 10% RH
- Devices require bake, before mounting, if:
 a.Humidity Indicator Card is > 65% when read at 23±5°C, or
 b. 2a is not met.
- 5. If baking is required, devices must be baked for 1 hours at 60±5°C Note: if device containers cannot be subjected to high temperature or shorter bake times are desired, reference IPC/JEDEC J-STD-033 for bake procedure,

Bag seal due date: __

(if blank, see code label)

Note: Level and body temperature by IPC/JEDEC J-STD-020

Con mex





LM101A [CRI] [CCT]

SCP8WT78HPL1WLS06E WLSC6A

SAMSUNG

1234567889/labc/4,000 pcs

WLSC6A



■ 주의 사항

이 알루미늄 지퍼 백은 습기 및 정전기로부터 제품을 보호하 기 위하여 제작되었습니다. 개봉 후에는 즉시 솔더 작업을 실 시하는 것을 권장합니다.

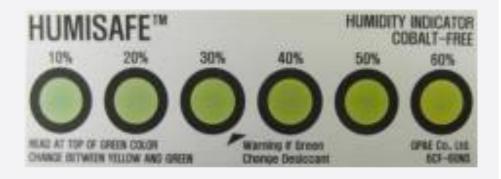
습기 및 정전기로부터 제품을 보호 하기 위해서 개봉 후 사용 하지 않는 자재는 본 팩에 넣어 보관 하시기 바랍니다. 사용하 지 않는 자재를 본 팩에 넣을 때는 반드시 동봉된 드라이 팩 과 함께 넣고 지퍼부분을 완전하게 밀봉하여 주시기 바랍니다.

■ Important

This Al Zipper bag is designed to protect the enclosed products from moisture and ESD. Once opened, the products should be soldered onto the printed circuit board immediately. When not in use, please do not leave the products unprotected by the Al Zipper Bag. To repack unused products., please ensure the zip-lock is completely sealed with the dry pack left inside.

c) Silica Gel & Humidity Indicator Card inside Aluminum Vinyl Bag





10. Precautions in Handling & Use

- 1) For over-current-proof function, customers are recommended to apply resistors to prevent sudden change of the current caused by slight shift of the voltage.
- 2) This device should not be used in any type of fluid such as water, oil, organic solvent, etc. When washing is required, IPA is recommended to use.
- 3) When the LEDs illuminate, operating current should be decided after considering the ambient maximum temperature.
- 4) LEDs must be stored in a clean environment. If the LEDs are to be stored for three months or more after being shipped from Samsung, they should be packed by a sealed container with nitrogen gas injected (shelf life of sealed bags: 12 months, temperature ~40 °C, ~90 % RH).
- 5) After storage bag is opened, device subjected to soldering, solder reflow, or other high temperature processes must be:
 - a. Mounted within 672 hours (28 days) at an assembly line with a condition of no more than 30 °C / 60 % RH, or
 - b. Stored at <10 % RH
- 6) Repack unused products with anti-moisture packing, fold to close any opening and then store in a dry place.
- 7) Devices require baking before mounting, if humidity card reading is >60 % at 23 \pm 5 °C.
- 8) Devices must be baked for 1 hour at 60 ± 5 °C, if baking is required.
- 9) The LEDs are sensitive to the static electricity and surge. It is recommended to use a wrist band or anti-electrostatic glove when handling the LEDs. If voltage exceeding the absolute maximum rating is applied to LEDs, it may cause damage or even destruction to LED devices. Damaged LEDs may show some unusual characteristics such as increase in leak current, lowered turn-on voltage, or abnormal lighting of LEDs at low current.
- 10) VoCs (Volatile Organic Compounds) can be generated from adhesives, flux, hardener or organic additives used in luminaires (fixtures). LED silicone encapsulant is permeable to those chemicals and they may lead to a discoloration of encapsulant when they exposed to heat or light. This phenomenon can cause a significant loss of light emitted (output) from the luminaires. In order to prevent these problems, we recommend users to know the physical properties of materials used in luminaires and they must be carefully selected.
- 11) Risk of sulfurization (or tarnishing)
 - The LED from Samsung does not use a silver-plated lead frame but if the LED is attached in silver-plated substrate, the surface color of substrate may change to black (or dark colored) when it is exposed to sulfur (S), chlorine (Cl) or other halogen compound. Sulfurization of substrate may cause intensity degradation, change of chromaticity coordinates and, in extreme cases, open circuit, It requires caution. Due to possible sulfurization of substrate, LED should not be used and stored together with oxidizing substances made of materials such as rubber, plain paper, lead solder cream, etc.

Legal and additional information.

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US\$216.7 billion. To discover more, please visit www.samsungled.com.

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